

Issue Classification

Application/Control No.

10698666

Applicant(s)/Patent Under Reexamination

HUSTED, PAUL J.

Examiner

Lee, Siu M.

Art Unit

2611

ORIGINAL

CLASS

SUBCLASS

375

316

CROSS REFERENCE(S)

CLASS

SUBCLASS (ONE SUBCLASS PER BLOCK)

375

341

262

340

260

368

455

219

232.1

234.1

234.2

226.1

INTERNATIONAL CLASSIFICATION

CLAIMED

NON-CLAIMED

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4

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27 / 00 (2006.01.01)

Lee, Siu M

2/13/2008

(Assistant Examiner)

(Date)

Total Claims Allowed:

21

(Legal Instruments
Examiner)

(Date)

CHIEH M. FAN
SUPERVISORY PATENT EXAMINER
(Primary Examiner)

O.G. Print Claim(s)

1

O.G. Print Figure

4